

## 60V N-Channel Enhancement Mode MOSFET

### Description

The AP2N06BI uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### General Features

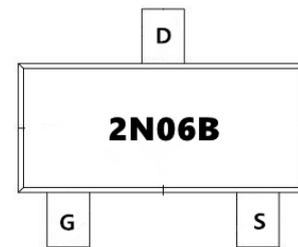
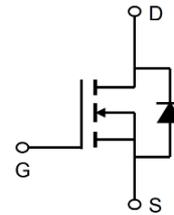
$V_{DS}=60V$   $I_D=2.0A$

$R_{DS(ON)} < 185m\Omega$  @  $V_{GS}=10V$  (Type: 135m $\Omega$ )

### Application

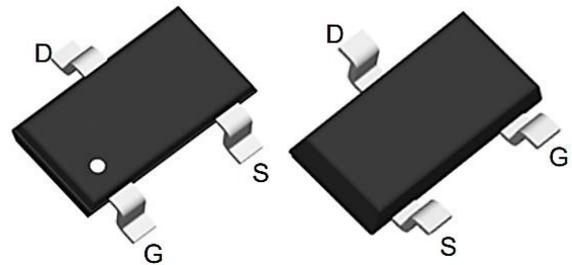
Load switch

Uninterruptible power supply



Top View

Bottom View



### Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP2N06BI	SOT23L	2N06B	3000

### Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	60	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D@T_C=25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10V^1$	2.0	A
$I_D@T_C=100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10V^1$	1.1	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	6	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	11	mJ
$P_D@T_C=25^\circ\text{C}$	Total Power Dissipation <sup>4</sup>	42	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance Junction-ambient <sup>1</sup>	128	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	3	$^\circ\text{C/W}$

## 60V N-Channel Enhancement Mode MOSFET

### Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

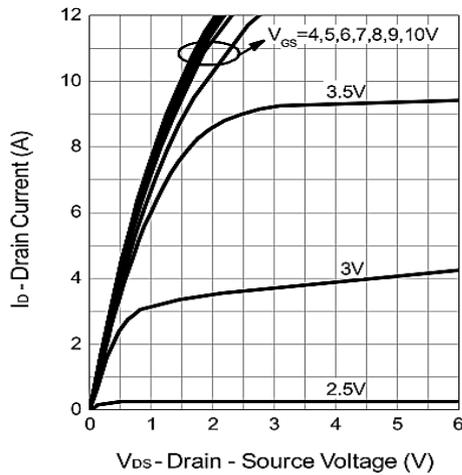
Symbol	Parameter	Conditions	Min	Typ	Max	Units
BVDSS	Drain-Source Breakdown Voltage	VGS=0V, ID=250μA	60	66		V
IDSS	Zero Gate Voltage Drain Current	VDS=60V, VGS=0V			1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V, VDS=0V			±100	nA
		VGS=±10V, VDS=0V			±50	
VGS(th)	Gate Threshold Voltage	VDS= VGS, ID=250μA	1.0	1.6	2.5	V
RDS(ON)	Static Drain-Source On-Resistance	VGS=10V, ID=1.6A		135	180	mΩ
		VGS=4.5V, ID=1A		165	225	
Ciss	Input Capacitance	VDS=10V, VGS=0V, f=1MHZ		205		pF
Coss	Output Capacitance			25		pF
Crss	Reverse Transfer Capacitance			10		pF
Qg	Total Gate Charge	VGS=10V, VDS=30V, ID=3A		2.5		nC
Qgs	Gate-Source Charge			5		nC
Qgd	Gate-Drain Charge			1		nC
Qrr	Reverse Recovery Charge	IF=1A, di/dt=100A/us		14		nC
trr	Reverse Recovery Time			16		ns
tD(on)	Turn-on Delay Time	VGS=10V, VDS=30V, RL=20Ω RGEN=3Ω		6		ns
tr	Turn-on Rise Time			9		ns
tD(off)	Turn-off Delay Time			12		ns
tf	Turn-off fall Time			3		ns
VSD	Diode Forward Voltage	IS=1A, VGS=0V			1.3	V

#### Note :

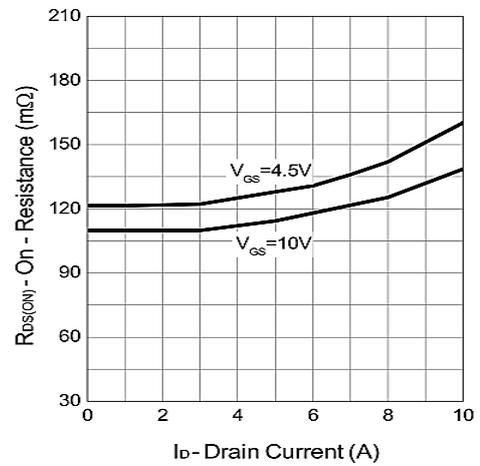
- 1、 The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
- 3、 The power dissipation is limited by 150°C junction temperature
- 4、 The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.

**60V N-Channel Enhancement Mode MOSFET**

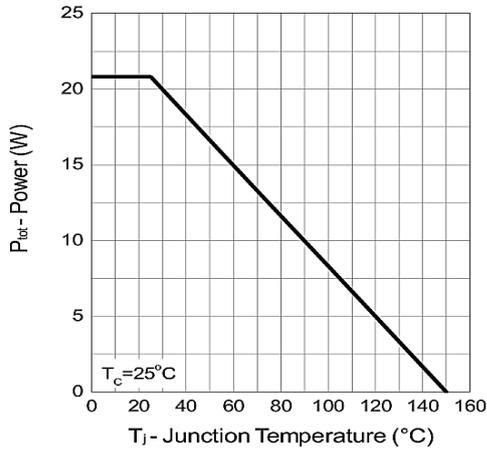
**Typical Characteristics**



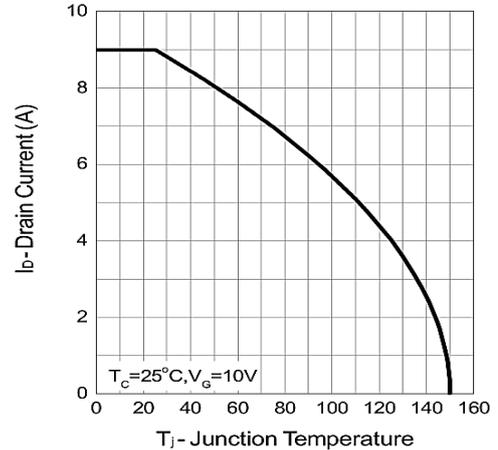
**Figure1: Output Characteristics**



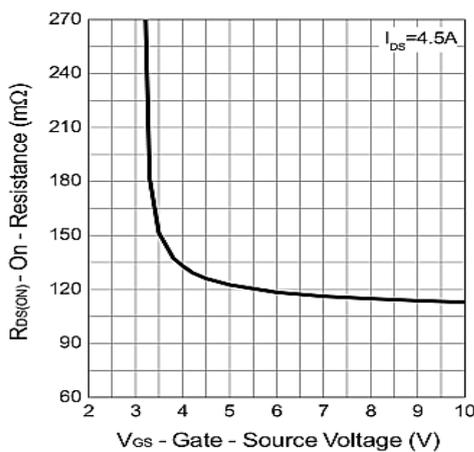
**Figure2: Drain-Source On Resistance**



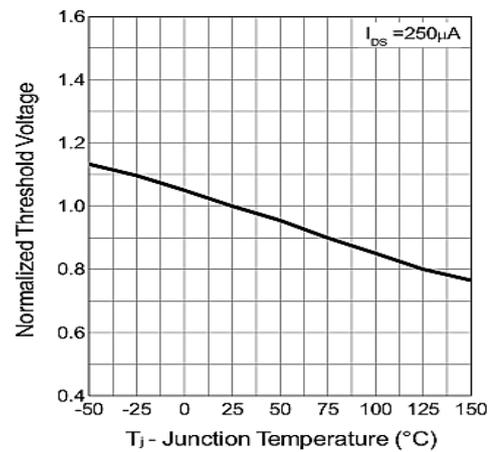
**Figure3: Power Dissipation**



**Figure4: Drain Current**

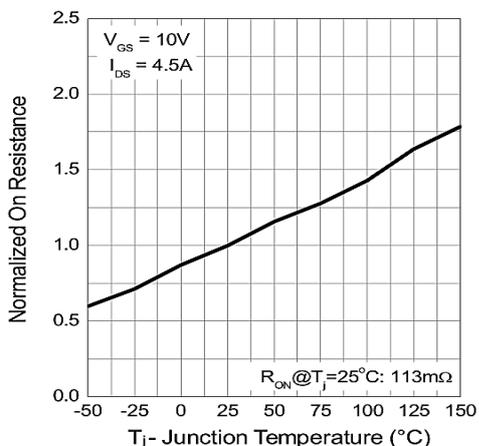


**Figure5: Gate-Source On Resistance**

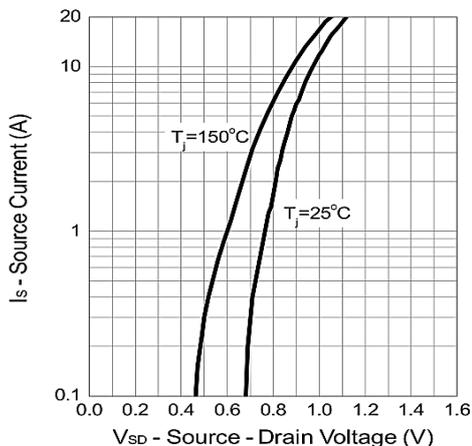


**Figure6: Gate Threshold Voltage**

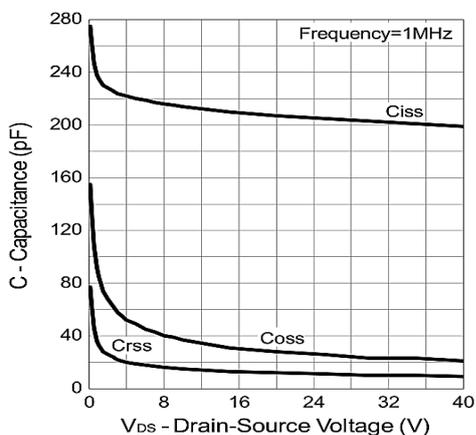
**60V N-Channel Enhancement Mode MOSFET**



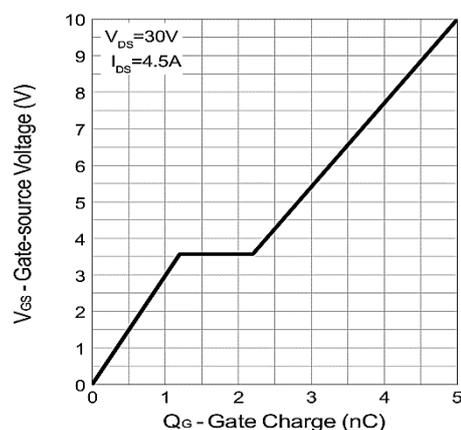
**Figure7: Drain-Source On Resistance**



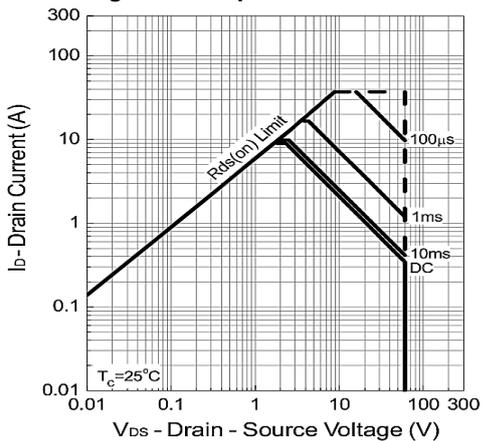
**Figure8: Source-Drain Diode Forward**



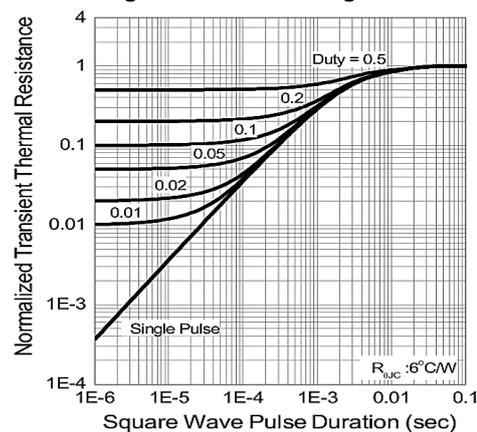
**Figure9: Capacitance**



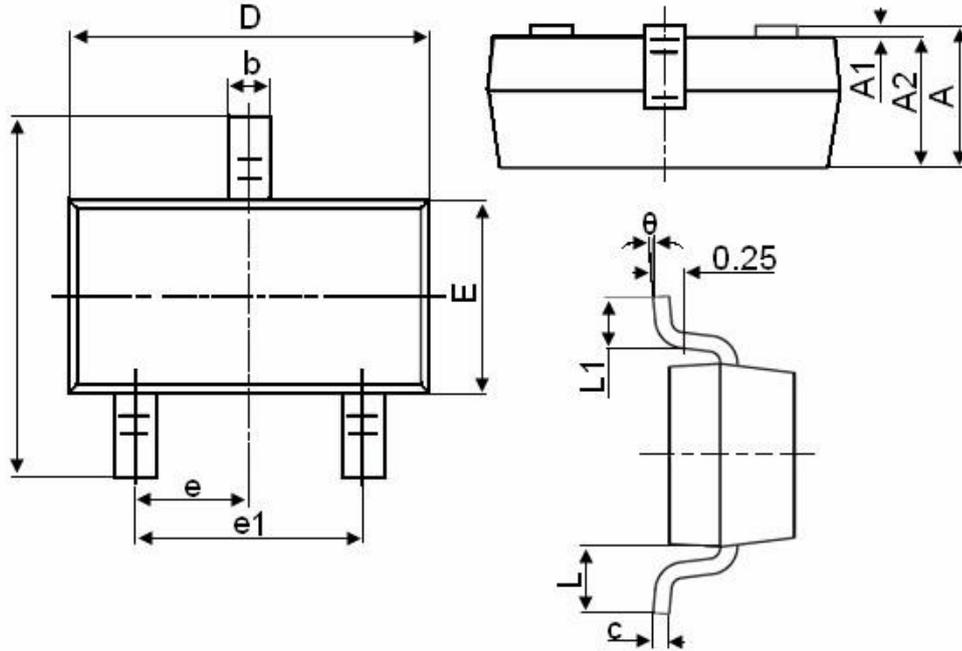
**Figure10: Gate Charge**



**Figure11: Safe Operation Area**



**Figure12: Thermal Transient Impedance**

**Package Mechanical Data-SOT23-XC-Single**


Symbol	Dimensions in Millimeters	
	MIN.	MAX.
A	0.900	1.150
A1	0.000	0.100
A2	0.900	1.050
b	0.300	0.500
c	0.080	0.150
D	2.800	3.000
E	1.200	1.400
E1	2.250	2.550
e	0.950TYP	
e1	1.800	2.000
L	0.550REF	
L1	0.300	0.500
$\theta$	0°	8°